

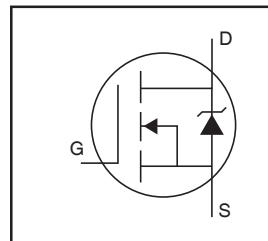
**AUIRL1404S**  
**AUIRL1404L**  
HEXFET® Power MOSFET

**Features**

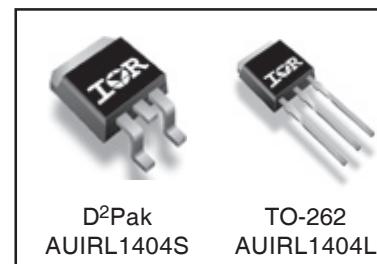
- Advanced Planar Technology
- Logic-Level Gate Drive
- Low On-Resistance
- Dynamic dV/dT Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

**Description**

Specifically designed for Automotive applications, this Stripe Planar design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



<b>V<sub>(BR)DSS</sub></b>	<b>40V</b>
<b>R<sub>DS(on)</sub> max.</b>	<b>4mΩ</b>
<b>I<sub>D</sub></b>	<b>160A<sup>⑥</sup></b>



<b>G</b>	<b>D</b>	<b>S</b>
Gate	Drain	Source

**Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T<sub>A</sub>) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	160 <sup>⑥</sup>	A
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	110 <sup>⑥</sup>	
I <sub>DM</sub>	Pulsed Drain Current ①	640	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Power Dissipation	3.8	W
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Power Dissipation	200	
	Linear Derating Factor	1.3	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	±20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy ②	520	mJ
I <sub>AR</sub>	Avalanche Current ①	95	A
E <sub>AR</sub>	Repetitive Avalanche Energy ①	20	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 175	°C
T <sub>STG</sub>	Storage Temperature Range		
	Soldering Temperature, for 10 seconds		

**Thermal Resistance**

	Parameter	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case	—	0.75	°C/W
R <sub>θCS</sub>	Case-to-Sink, Flat, Greased Surface	0.50	—	
R <sub>θJA</sub>	Junction-to-Ambient (PCB mounted)⑦	—	40	

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\*Qualification standards can be found at <http://www.irf.com/>

**Static Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	40	—	—	V	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.038	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	4.0	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}, I_D = 95\text{A}$ ④
		—	—	5.9		$V_{\text{GS}} = 4.3\text{V}, I_D = 40\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	1.0	—	3.0	V	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$
$g_{\text{fs}}$	Forward Transconductance	93	—	—	S	$V_{\text{DS}} = 25\text{V}, I_D = 95\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$V_{\text{DS}} = 40\text{V}, V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 32\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 150^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	200	$\text{nA}$	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{\text{GS}} = -20\text{V}$

**Dynamic Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

$Q_g$	Total Gate Charge	—	—	140	nC	$I_D = 95\text{A}$ $V_{\text{DS}} = 32\text{V}$ $V_{\text{GS}} = 5.0\text{V}$ , See Fig 6 ④
$Q_{\text{gs}}$	Gate-to-Source Charge	—	—	48		
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	—	60		
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	18	—		
$t_r$	Rise Time	—	270	—	ns	$V_{\text{DD}} = 20\text{V}$ $I_D = 95\text{A}$ $R_G = 2.5\Omega, V_{\text{GS}} = 4.5\text{V}$ $R_D = 0.25\Omega$ ④
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	38	—		
$t_f$	Fall Time	—	130	—		
$L_D$	Internal Drain Inductance	—	4.5	—		Between lead, 6mm (0.25in.)
$L_S$	Internal Source Inductance	—	7.5	—	nH	Between lead, and center of die contact
$C_{\text{iss}}$	Input Capacitance	—	6600	—	pF	$V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = 25\text{V}$ $f = 1.0\text{MHz}$ , See Fig.5
$C_{\text{oss}}$	Output Capacitance	—	1700	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 1.0\text{V}, f = 1.0\text{MHz}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	350	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 32\text{V}, f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	6700	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V to } 32\text{V}$
$C_{\text{oss eff.}}$	Effective Output Capacitance ⑤	—	1500	—		

**Diode Characteristics**

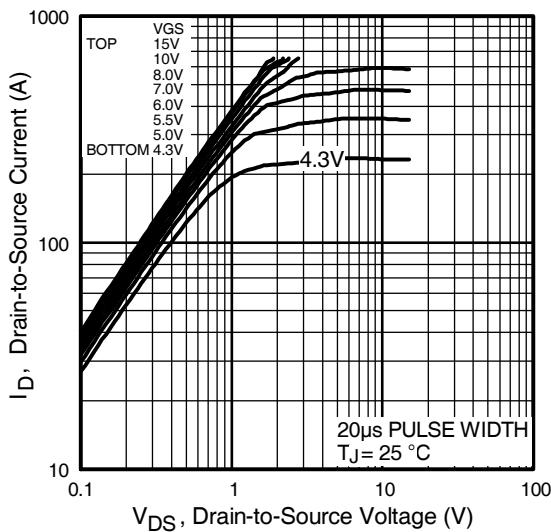
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	160 ⑥	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	640		
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.3		$T_J = 25^\circ\text{C}, I_S = 95\text{A}, V_{\text{GS}} = 0\text{V}$ ④
$t_{\text{rr}}$	Reverse Recovery Time	—	63	94		$T_J = 25^\circ\text{C}, I_F = 95\text{A}$ $dI/dt = 100\text{A}/\mu\text{s}$ ④
$Q_{\text{rr}}$	Reverse Recovery Charge	—	170	250	nC	
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

**Notes:**

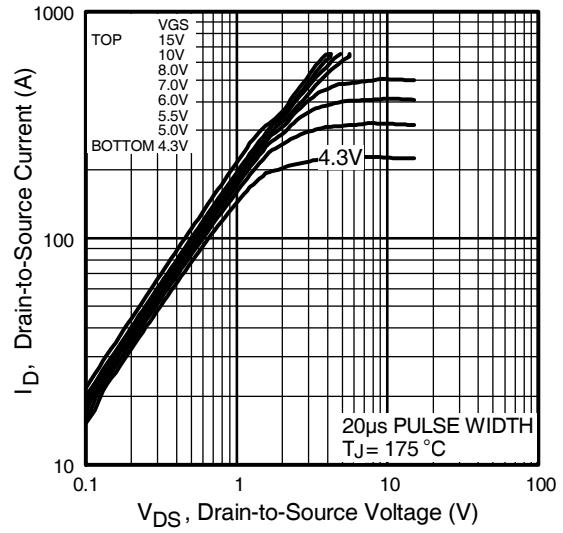
- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.35\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 95\text{A}$ . (See Figure 12)
- ③  $I_{SD} \leq 95\text{A}$ ,  $dI/dt \leq 160\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  $T_J \leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $C_{\text{oss eff.}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 80%  $V_{\text{DSS}}$ .

⑥ Calculated continuous current based on maximum allowable junction temperature; for recommended current-handling of the package refer to Design Tip # 93-4.

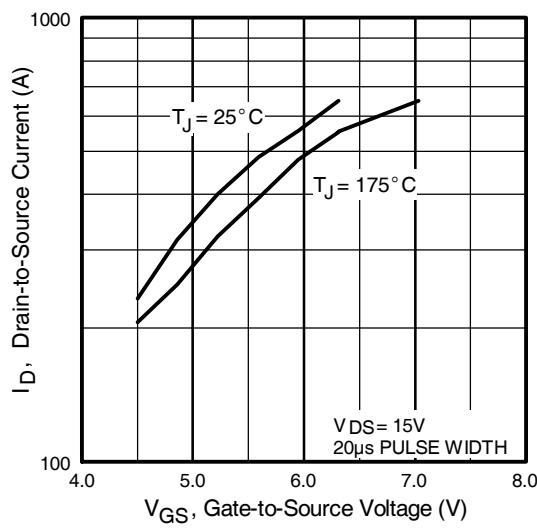
⑦ This is applied to D<sup>2</sup>Pak, When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.



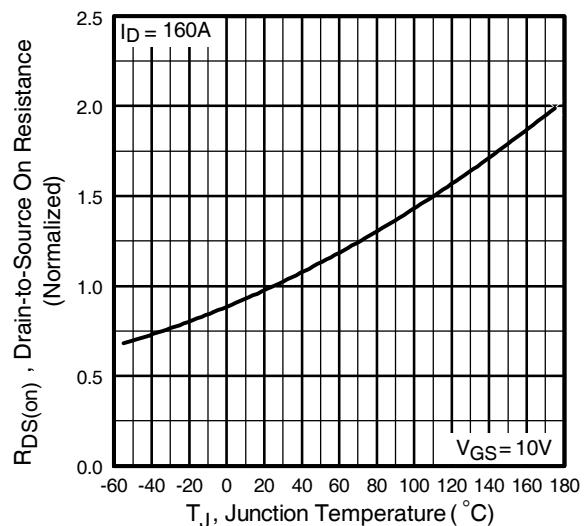
**Fig 1.** Typical Output Characteristics



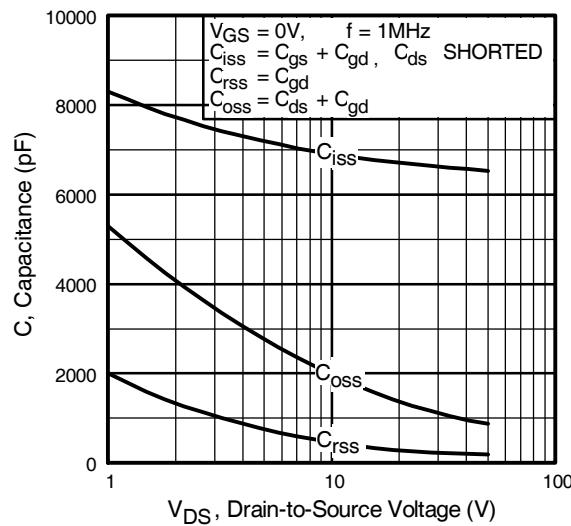
**Fig 2.** Typical Output Characteristics



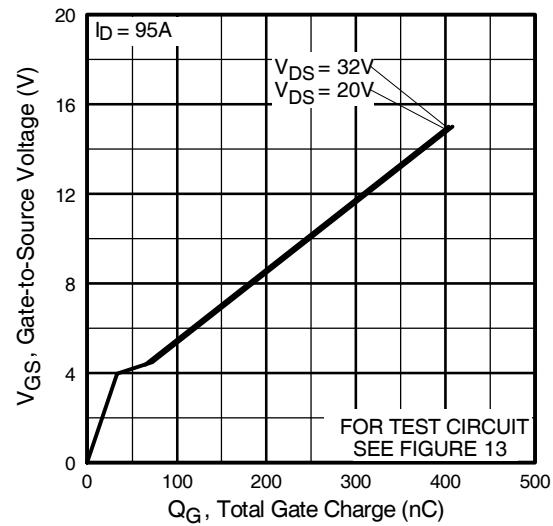
**Fig 3.** Typical Transfer Characteristics



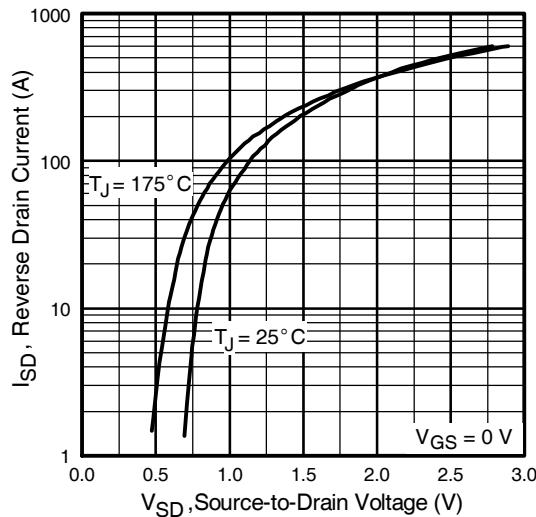
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



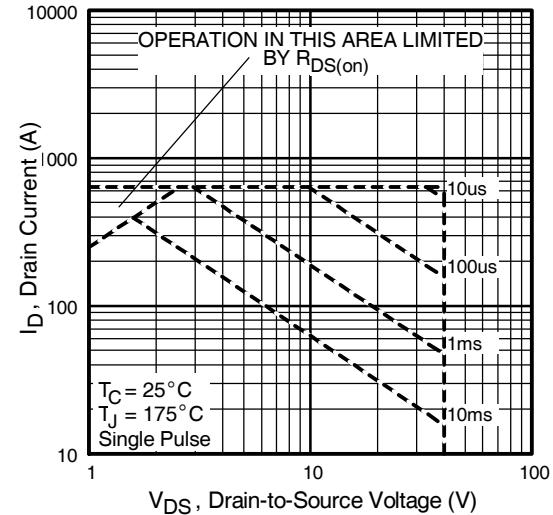
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



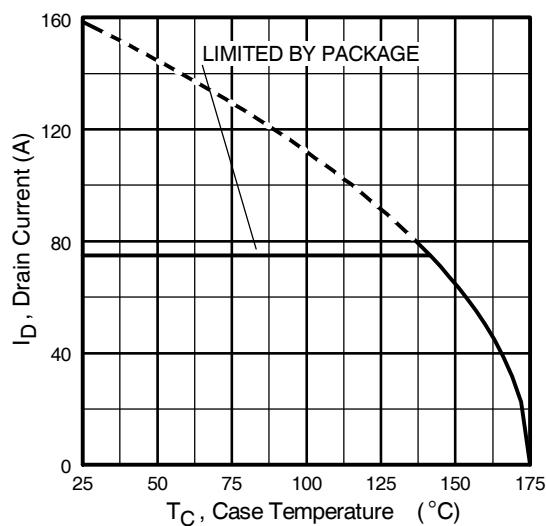
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



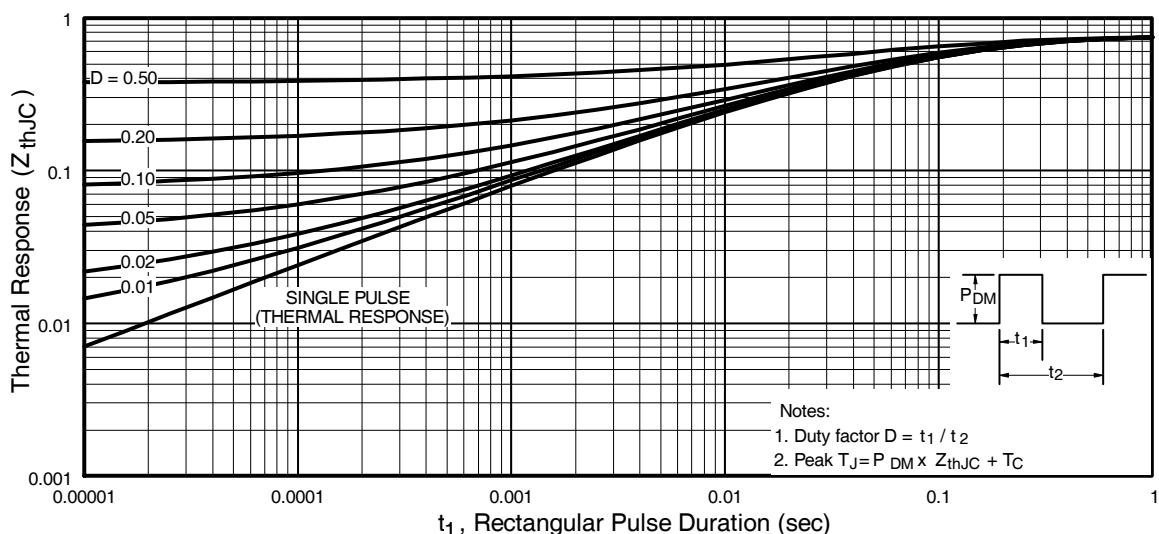
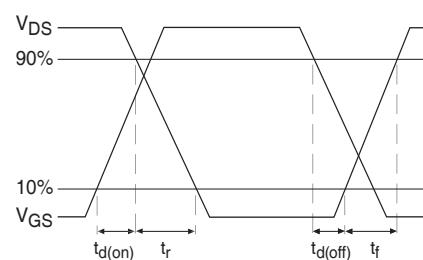
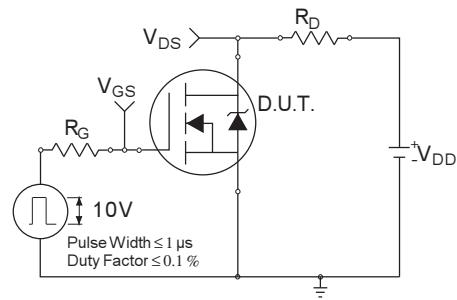
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



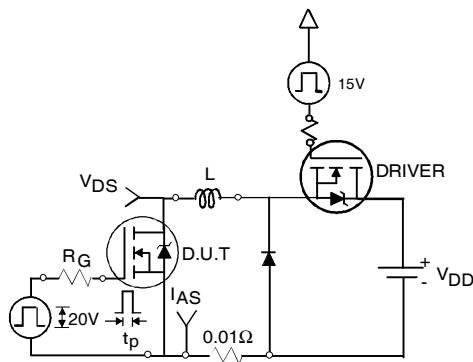
**Fig 8.** Maximum Safe Operating Area



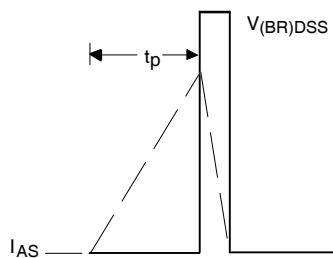
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



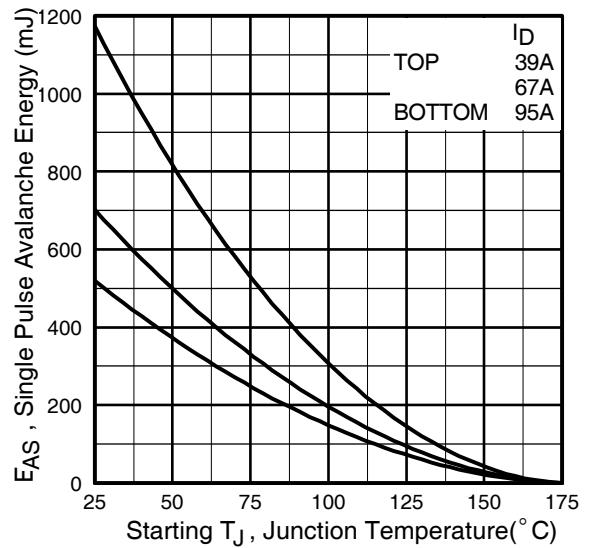
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



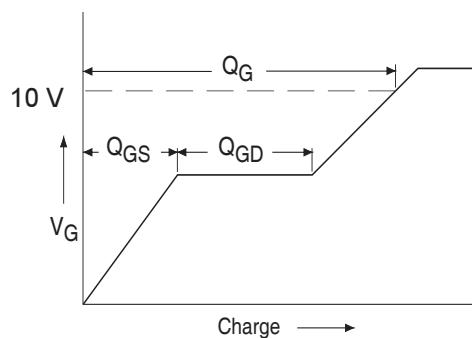
**Fig 12a.** Unclamped Inductive Test Circuit



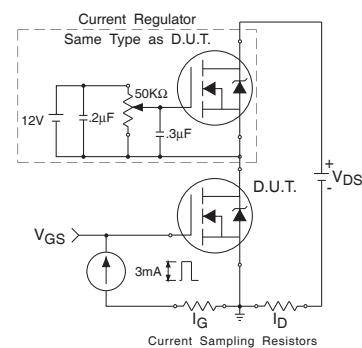
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

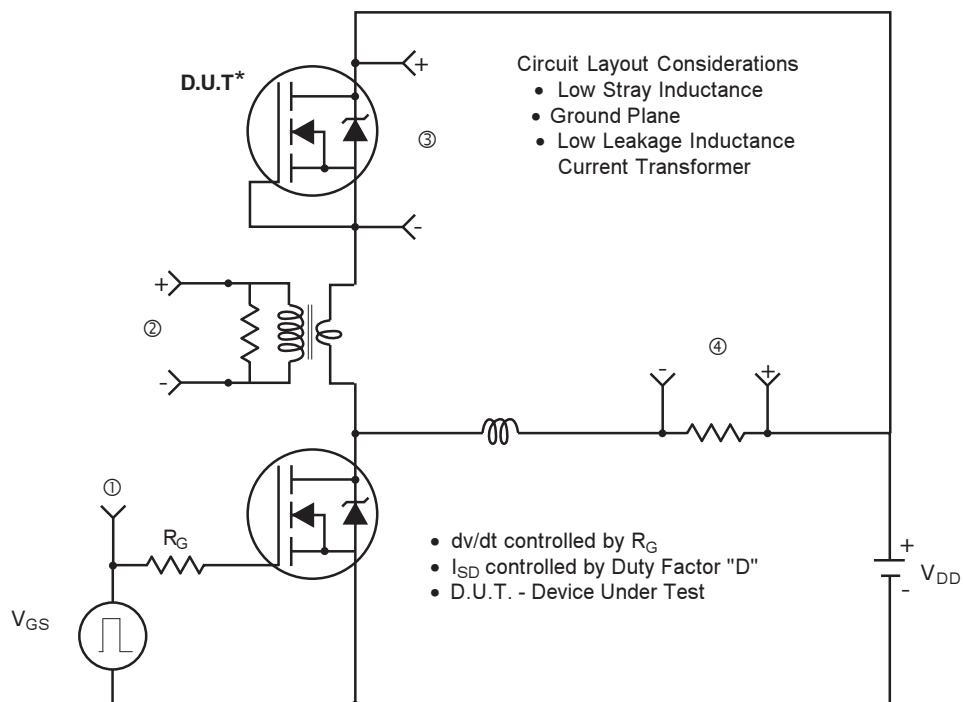


**Fig 13a.** Basic Gate Charge Waveform

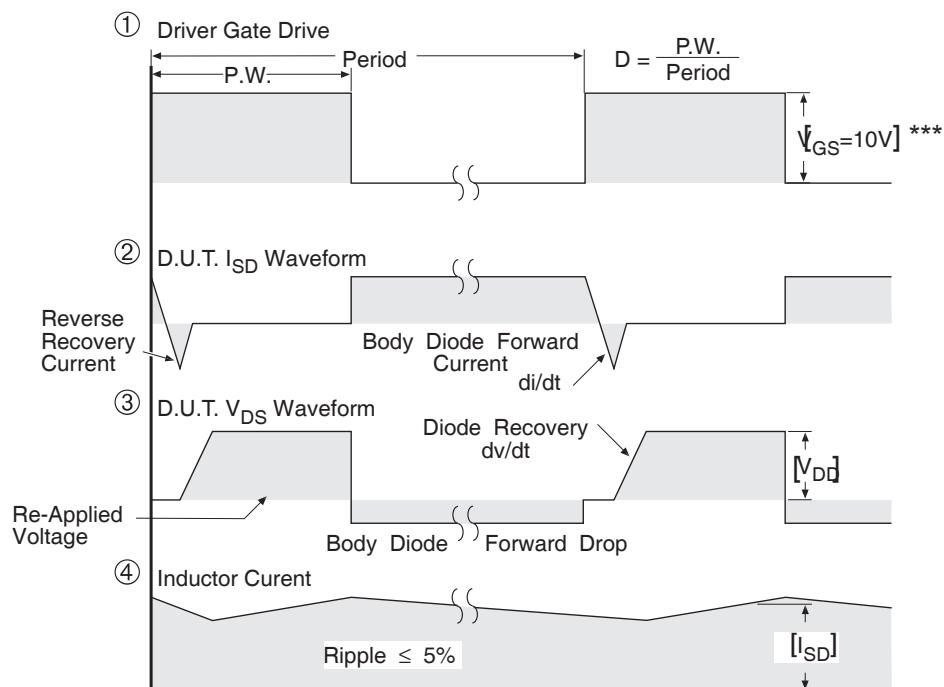


**Fig 13b.** Gate Charge Test Circuit

### Peak Diode Recovery dv/dt Test Circuit

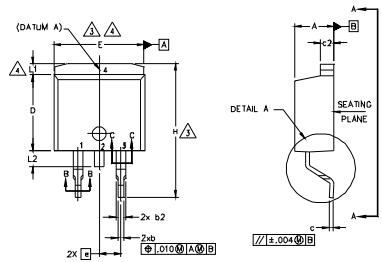


\* Reverse Polarity of D.U.T for P-Channel



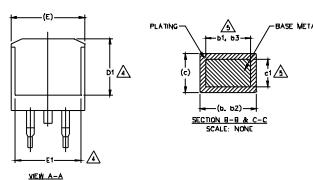
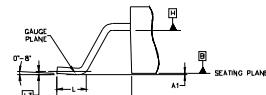
\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

Fig 14. For N-channel HEXFET® power MOSFETs

D<sup>2</sup>Pak Package Outline (Dimensions are shown in millimeters (inches))

## NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
7. CONTROLLING DIMENSION: INCH.
8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.



SYMBOL	DIMENSIONS		NOTES	
	MILLIMETERS	INCHES		
	MIN.	MAX.	MIN.	MAX.
A	4.06	4.83	.160	.190
A1	0.00	0.254	.000	.010
b	0.51	0.99	.020	.039
b1	0.51	0.89	.020	.035
b2	1.14	1.78	.045	.070
b3	1.14	1.73	.045	.068
c	0.38	0.74	.015	.029
c1	0.38	0.58	.015	.023
c2	1.14	1.65	.045	.065
D	8.38	9.65	.330	.380
D1	6.86	—	.270	.380
E	9.65	10.67	.380	.420
E1	6.22	—	.245	.245
e	2.54 BSC	—	.100 BSC	—
H	14.61	15.88	.575	.625
L	1.78	2.79	.070	.110
L1	—	1.65	—	.066
L2	1.27	1.78	—	.070
L3	0.25 BSC	—	.010 BSC	—
L4	4.78	5.28	.188	.208

## LEAD ASSIGNMENTS

## HEXFET

- 1.— GATE
- 2, 4.— DRAIN
- 3.— SOURCE

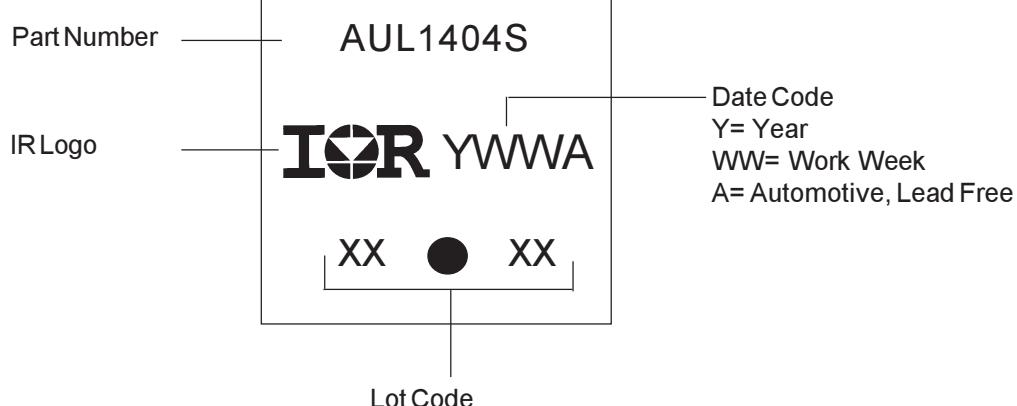
## IGBTs, CoPACK

- 1.— GATE
- 2, 4.— COLLECTOR
- 3.— Emitter

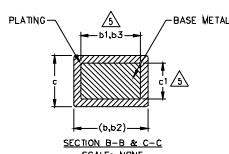
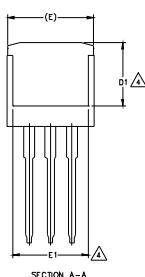
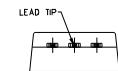
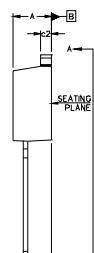
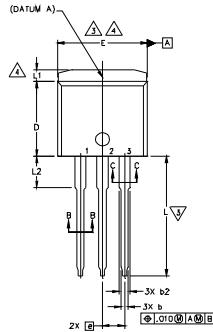
## DIODES

- 1.— ANODE \*
- 2, 4.— CATHODE
- 3.— ANODE

\* PART DEPENDENT.

D<sup>2</sup>Pak Part Marking InformationNote: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

## TO-262 Package Outline ( Dimensions are shown in millimeters (inches))



### NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
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4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
6. CONTROLLING DIMENSION: INCH.
7. OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

S Y M B O L	DIMENSIONS				N O T E S	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	4.06	4.83	.160	.190		
A1	2.03	3.02	.080	.119		
b	0.51	0.99	.020	.039		
b1	0.51	0.89	.020	.035	5	
b2	1.14	1.78	.045	.070		
b3	1.14	1.73	.045	.068	5	
c	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1.14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	—	.270	—	4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	—	.245	—	4	
e	2.54	BSC	.100	BSC		
L	13.46	14.10	.530	.555		
L1	—	1.65	—	.065	4	
L2	3.56	3.71	.140	.146		

### LEAD ASSIGNMENTS

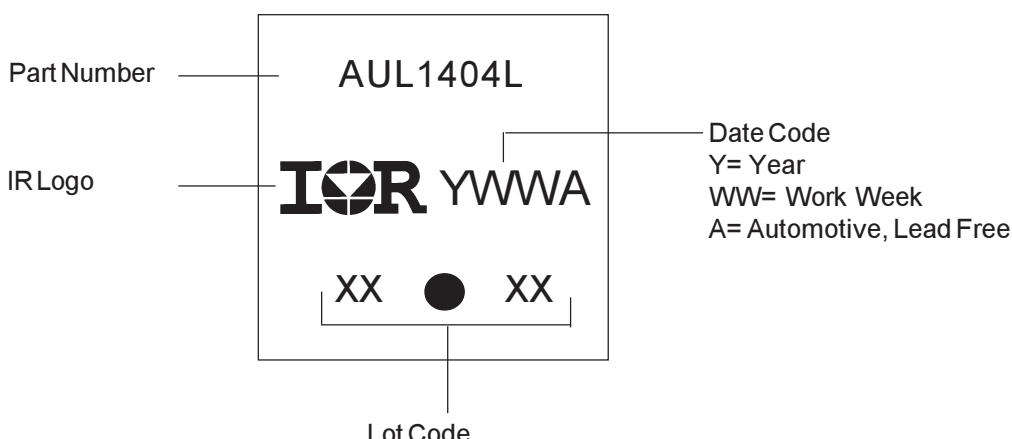
#### HEXFET

1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

#### IGBTs, CoPACK

1. GATE
2. COLLECTOR
3. Emitter
4. COLLECTOR

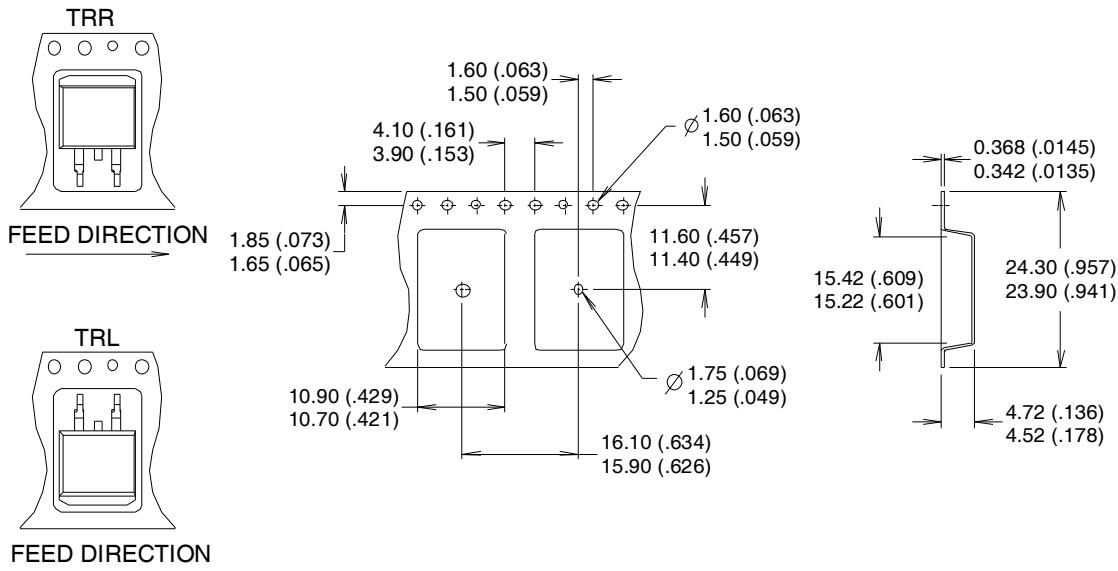
## TO-262 Part Marking Information



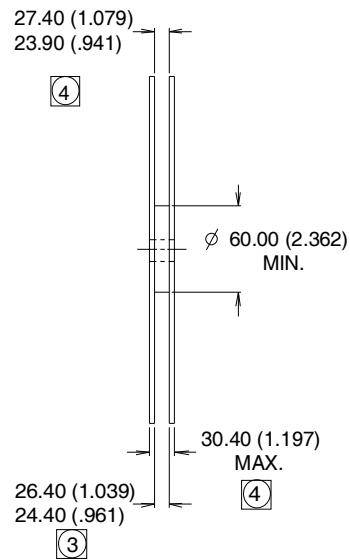
Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**D<sup>2</sup>Pak Tape & Reel Information**

Dimensions are shown in millimeters (inches)

**NOTES :**

1. COMFORMS TO EIA-418.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION MEASURED @ HUB.
4. INCLUDES FLANGE DISTORTION @ OUTER EDGE.



### Ordering Information

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUURL1404L	TO-262	Tube	50	AUURL1404L
AUURL1404S	D2Pak	Tube	50	AUURL1404S
		Tape and Reel Left	800	AUURL1404STRL
		Tape and Reel Right	800	AUURL1404STRR

**IMPORTANT NOTICE**

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**WORLD HEADQUARTERS:**  
101 N. Sepulveda Blvd., El Segundo, California 90245  
Tel: (310) 252-7105